

Application/Control No.	Applicant(s)/Patent under Reexamination	,
10/706,503	PARK, IL-YONG	
Examiner	Art Unit	_
Christopher M. Kachler	3726	

	SEAR	CHED	
Class	Subclass	Date	Examiner
427	202-206 214 216 217	5/23/2006	СМК
205	205-229	5/23/2006	СМК
205	271 135	5/23/2006	СМК
51	295	5/23/2006	СМК
UPDATED	ABOVE	11/3/2006	СМК

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
		-
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Search Notes

Application/Control No.

10/706,503

Examiner

Christopher M. Koehler

Applicant(s)/Patent under Reexamination

PARK, IL-YONG

Art Unit

3726

	SEAR	CHED	
Class	Subclass	Date	Examiner
451	527-530 533 534 539 29-31	5/23/2006	СМК
132	76.4 76.5	5/23/2006	СМК
132	73	5/23/2006	СМК
407	29.1	5/23/2006	СМК
407	29.14	5/23/2006	СМК
407	29.15	5/23/2006	СМК
29	527.1	5/23/2006	СМК
29	527.2	5/23/2006	СМК
29	DIG.12	5/23/2006	СМК
427	258 259	5/23/2006	СМК
427	261 282	5/23/2006	СМК
427	287 438	5/23/2006	СМК
427	468 470	5/23/2006	СМК
427	526 531	5/23/2006	СМК

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
Inventor name and IDS search	5/23/2006	СМК
EAST text, FWD, BKWD search notes attached	5/23/2006	СМК
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